

# Silicon Carbide (SiC) Module – EliteSiC, 40 mohm SiC M1 MOSFET, 1200 V + 40 A, 1200 V SiC Diode, Two Channel Full SiC Boost, Q0 Package

## NXH40B120MNQ0SNG

### Description

The NXH40B120MNQ0SNG is a power module containing a dual boost stage. The integrated SiC MOSFETs and SiC Diodes provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

### Features

- 1200 V, 40 mΩ SiC MOSFETs
- Low Reverse Recovery and Fast Switching SiC Diodes
- 1200 V Bypass and Anti-parallel Diodes
- Low Inductive Layout
- Solder Pins
- Thermistor
- These Device is Pb-Free, Halogen Free and is RoHS Compliant

### Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies

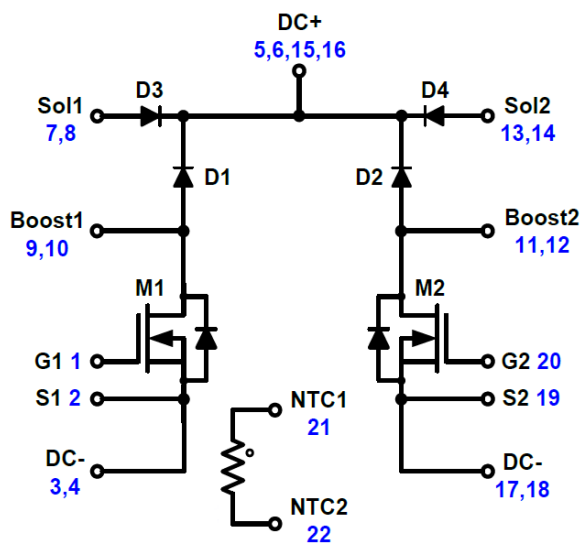
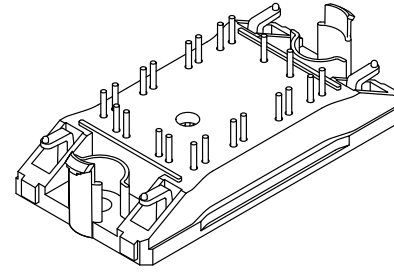
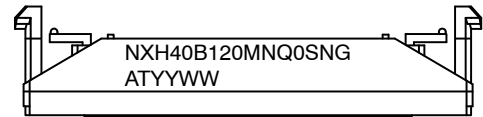


Figure 1. NXH40B120MNQ0SNG Schematic Diagram



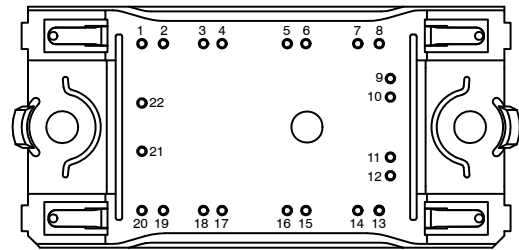
Q0BOOST  
CASE 180AJ  
SOLDER PINS

### MARKING DIAGRAM



A = Assembly Site Code  
T = Test Site Code  
G = Pb-Free Package  
YYWW = Year and Work Week Code  
NXH40B120MNQ0SNG = Specific Device Code

### PIN CONNECTIONS



### ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

# NXH40B120MNQ0SNG

## ABSOLUTE MAXIMUM RATINGS (Note 1) ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
<b>BOOST MOSFET</b>			
Drain–Source Voltage	$V_{DS}$	1200	V
Gate–Source Voltage	$V_{GS}$	-15/+25	V
Continuous Drain Current (@ $V_{GS} = 20\text{ V}$ , $T_C = 80^\circ\text{C}$ )	$I_D$	38	A
Pulsed Drain Current @ $T_C = 80^\circ\text{C}$ ( $T_J = 175^\circ\text{C}$ )	$I_{D(Pulse)}$	114	A
Maximum Power Dissipation @ $T_C = 80^\circ\text{C}$ ( $T_J = 175^\circ\text{C}$ )	$P_{tot}$	118	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	175	$^\circ\text{C}$

## BOOST DIODE

Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Continuous Forward Current @ $T_C = 80^\circ\text{C}$	$I_F$	45	A
Repetitive Peak Forward Current ( $T_J = 175^\circ\text{C}$ , $t_p$ limited by $T_{Jmax}$ )	$I_{FRM}$	135	A
Maximum Power Dissipation @ $T_C = 80^\circ\text{C}$ ( $T_J = 175^\circ\text{C}$ )	$P_{tot}$	118	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	175	$^\circ\text{C}$

## BYPASS DIODE

Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Continuous Forward Current @ $T_C = 80^\circ\text{C}$ ( $T_J = 150^\circ\text{C}$ )	$I_F$	50	A
Repetitive Peak Forward Current ( $T_J = 150^\circ\text{C}$ , $t_p$ limited by $T_{Jmax}$ )	$I_{FRM}$	150	A
Power Dissipation Per Diode @ $T_C = 80^\circ\text{C}$ ( $T_J = 175^\circ\text{C}$ )	$P_{tot}$	61	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	$T_{JMAX}$	150	$^\circ\text{C}$

## THERMAL PROPERTIES

Storage Temperature Range	$T_{stg}$	-40 to 125	$^\circ\text{C}$
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## INSULATION PROPERTIES

Isolation Test Voltage, $t = 1\text{ sec}$ , 60 Hz	$V_{is}$	3000	$V_{RMS}$
Creepage Distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

## RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	$T_J$	-40	( $T_{Jmax} - 25$ )	$^\circ\text{C}$

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

# NXH40B120MNQ0SNG

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
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### BOOST MOSFET CHARACTERISTICS

Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V, T <sub>J</sub> = 25°C	I <sub>DSS</sub>	–	–	200	μA	
Static Drain-to-Source On Resistance	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 40 A, T <sub>J</sub> = 25°C	R <sub>DS(on)</sub>	–	40	55	mΩ	
	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 40 A, T <sub>J</sub> = 175°C		–	60	–		
Gate-Source Leakage Current	V <sub>GS</sub> = -15 V / +25 V, V <sub>DS</sub> = 0 V	I <sub>GSS</sub>	–	–	1	μA	
Turn-on Delay Time	T <sub>J</sub> = 25°C, V <sub>DS</sub> = 700 V, I <sub>D</sub> = 40 A, V <sub>GS</sub> = -5 V / 20 V, R <sub>G</sub> = 4.7 Ω	t <sub>d(on)</sub>	–	17	–	ns	
Rise Time		t <sub>r</sub>	–	7.5	–		
Turn-off Delay Time		t <sub>d(off)</sub>	–	43.8	–		
Fall Time		t <sub>f</sub>	–	17	–		
Turn-on Switching Loss per Pulse		E <sub>on</sub>	–	255	–		μJ
Turn-off Switching Loss per Pulse		E <sub>off</sub>	–	125.5	–		μJ
Turn-on Delay Time	T <sub>J</sub> = 125°C, V <sub>DS</sub> = 700 V, I <sub>D</sub> = 40 A, V <sub>GS</sub> = -5 V / 20 V, R <sub>G</sub> = 4.7 Ω	t <sub>d(on)</sub>	–	15.8	–	ns	
Rise Time		t <sub>r</sub>	–	7	–		
Turn-off Delay Time		t <sub>d(off)</sub>	–	46.5	–		
Fall Time		t <sub>f</sub>	–	13.5	–		
Turn-on Switching Loss per Pulse		E <sub>on</sub>	–	383	–		μJ
Turn-off Switching Loss per Pulse		E <sub>off</sub>	–	108.5	–		μJ
Input Capacitance	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz	C <sub>ies</sub>	–	3227	–	pF	
Output Capacitance		C <sub>oes</sub>	–	829	–	pF	
Reverse Transfer Capacitance		C <sub>res</sub>	–	19	–	pF	
Total Gate Charge	V <sub>DS</sub> = 600 V, I <sub>D</sub> = 20 A, V <sub>GS</sub> = 20 V, -15 V	Q <sub>g</sub>	–	146.72	–	nC	
Thermal Resistance – Chip-to-Case	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK	R <sub>thJC</sub>	–	0.81	–	K/W	
Thermal Resistance – Chip-to-Heatsink		R <sub>thJH</sub>	–	1.26	–	K/W	

### BOOST DIODE CHARACTERISTICS

Diode Reverse Leakage Current	V <sub>R</sub> = 1200 V	I <sub>R</sub>	–	–	400	μA
Diode Forward Voltage	I <sub>F</sub> = 40 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	–	1.50	1.75	V
	I <sub>F</sub> = 40 A, T <sub>J</sub> = 175°C		–	2.17	–	
Reverse Recovery Time	T <sub>J</sub> = 25°C V <sub>DS</sub> = 700 V, I <sub>D</sub> = 40 A V <sub>GS</sub> = -5 V / 20 V, R <sub>G</sub> = 4.7 Ω	t <sub>rr</sub>	–	16.7	–	ns
Reverse Recovery Charge		Q <sub>rr</sub>	–	329.6	–	nC
Peak Reverse Recovery Current		I <sub>RRM</sub>	–	34.3	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	6684	–	A/μs
Reverse Recovery Energy		E <sub>rr</sub>	–	176.6	–	μJ

# NXH40B120MNQ0SNG

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
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### BOOST DIODE CHARACTERISTICS

Reverse Recovery Time	$T_J = 125^\circ\text{C}$ $V_{DS} = 700\text{ V}$ , $I_D = 40\text{ A}$ $V_{GS} = -5\text{ V} / 20\text{ V}$ , $R_G = 4.7\ \Omega$	$t_{rr}$	–	16.9	–	ns
Reverse Recovery Charge		$Q_{rr}$	–	361	–	nC
Peak Reverse Recovery Current		$I_{RRM}$	–	37	–	A
Peak Rate of Fall of Recovery Current		$di/dt$	–	8067	–	A/ $\mu\text{s}$
Reverse Recovery Energy		$E_{rr}$	–	209.1	–	$\mu\text{J}$
Thermal Resistance – Chip-to-Case		Thermal grease, Thickness = 2.1 Mil $\pm 2\%$ $\lambda = 2.9\text{ W/mK}$	$R_{thJC}$	–	0.70	–
Thermal Resistance – Chip-to-Heatsink	$R_{thJH}$		–	1.14	–	K/W

### BYPASS DIODE CHARACTERISTICS

Diode Reverse Leakage Current	$V_R = 1200\text{ V}$ , $T_J = 25^\circ\text{C}$	$I_R$	–	–	250	$\mu\text{A}$
Diode Forward Voltage	$I_F = 50\text{ A}$ , $T_J = 25^\circ\text{C}$	$V_F$	–	1.11	1.3	V
	$I_F = 50\text{ A}$ , $T_J = 150^\circ\text{C}$		–	1.00	–	
Thermal Resistance – Chip-to-Case	Thermal grease, Thickness = 2.1 Mil $\pm 2\%$ $\lambda = 2.9\text{ W/mK}$	$R_{thJC}$	–	1.15	–	K/W
Thermal Resistance – Chip-to-Heatsink		$R_{thJC}$	–	1.75	–	K/W

### THERMISTOR CHARACTERISTICS

Nominal Resistance		$R_{25}$	–	22	–	k $\Omega$
Nominal Resistance	$T = 100^\circ\text{C}$	$R_{100}$	–	1486	–	$\Omega$
Deviation of R25		$\Delta R/R$	–5	–	5	%
Power Dissipation		$P_D$	–	200	–	mW
Power Dissipation Constant			–	2	–	mW/K
B-value	B (25/50), tolerance $\pm 3\%$		–	3950	–	K
B-value	B (25/100), tolerance $\pm 3\%$		–	3998	–	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### PACKAGE MARKING AND ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH40B120MNQ0SNG	NXH40B120MNQ0SNG	Q0PACK – Case 180AJ (Pb-Free and Halide-Free Solder Pins)	24 Units / Blister Tray

# NXH40B120MNQ0SNG

## TYPICAL CHARACTERISTICS – MOSFET, BOOST DIODE AND BYPASS DIODE

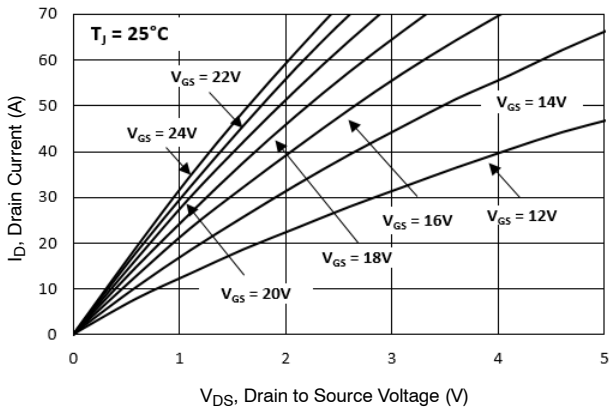


Figure 2. MOSFET on Region Characteristics

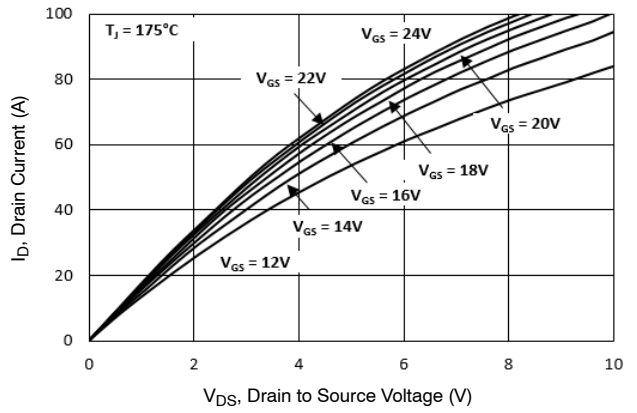


Figure 3. MOSFET on Region Characteristics

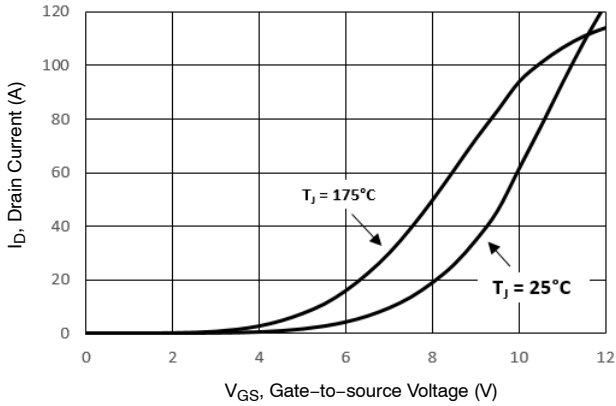


Figure 4. MOSFET Transfer Characteristics

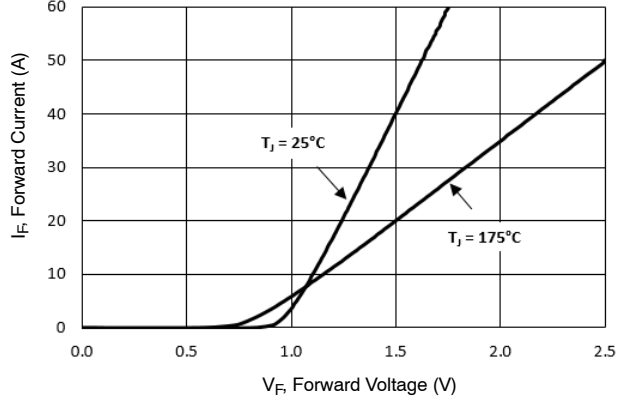


Figure 5. Boost Diode Forward Characteristics

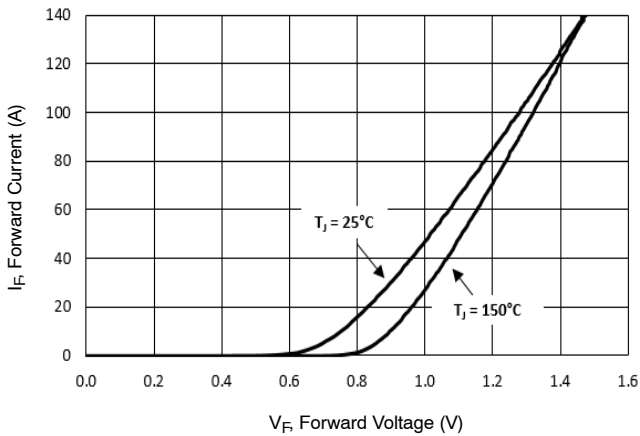


Figure 6. Bypass Diode Forward Characteristics

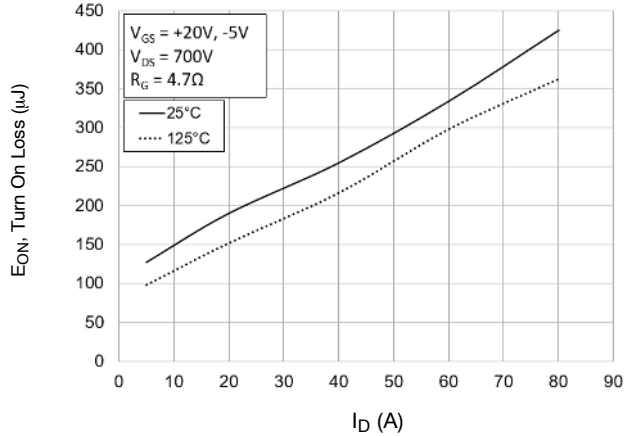


Figure 7. Typical Turn On Loss vs.  $I_D$

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## TYPICAL CHARACTERISTICS – MOSFET, BOOST DIODE AND BYPASS DIODE (continued)

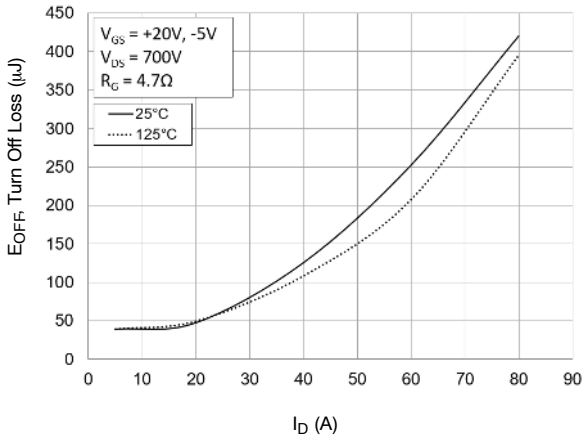


Figure 8. Typical Turn Off Loss vs.  $I_D$

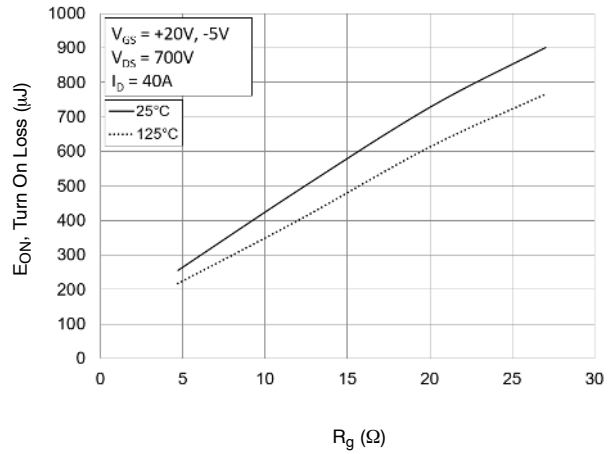


Figure 9. Typical Turn On Loss vs.  $R_G$

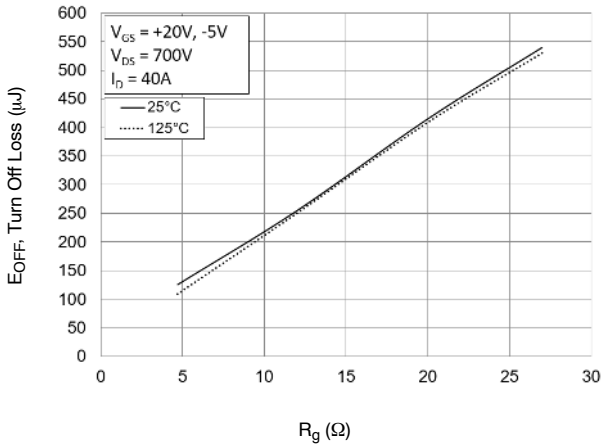


Figure 10. Typical Turn Off Loss vs.  $R_G$

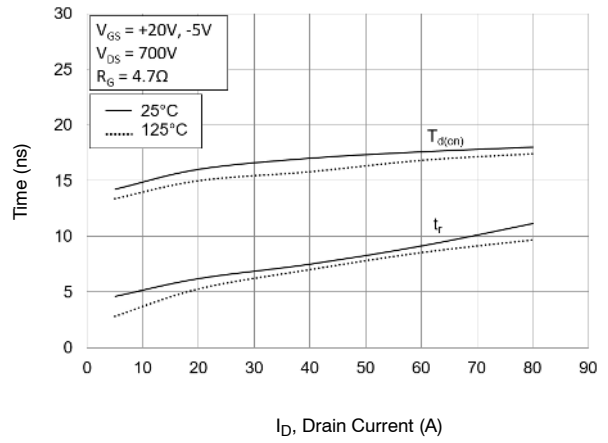


Figure 11. Typical Turn-On Switching Time vs.  $I_D$

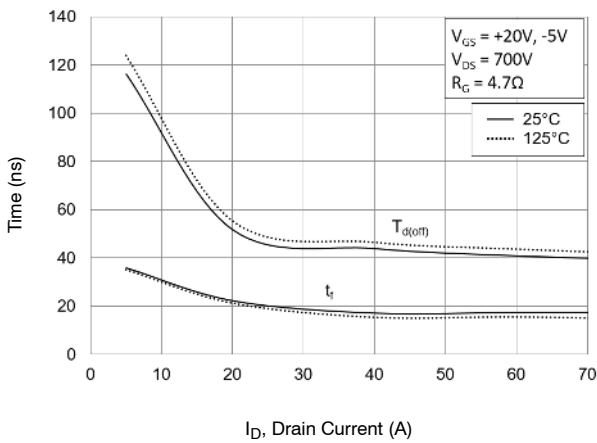


Figure 12. Typical Turn-Off Switching Time vs.  $I_D$

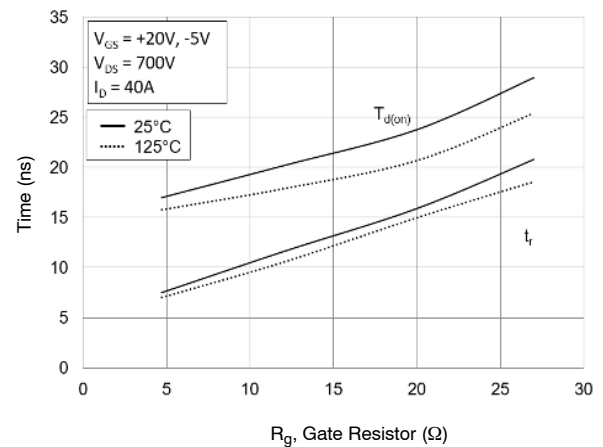
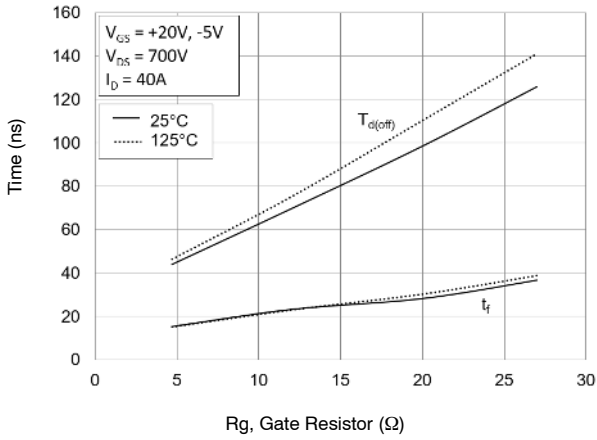


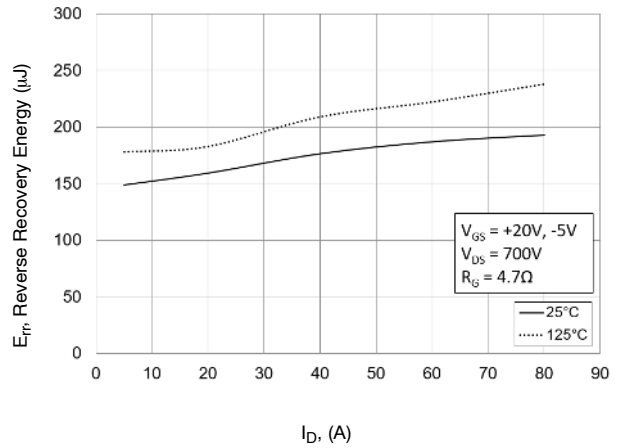
Figure 13. Typical Turn-On Switching Time vs.  $R_G$

# NXH40B120MNQ0SNG

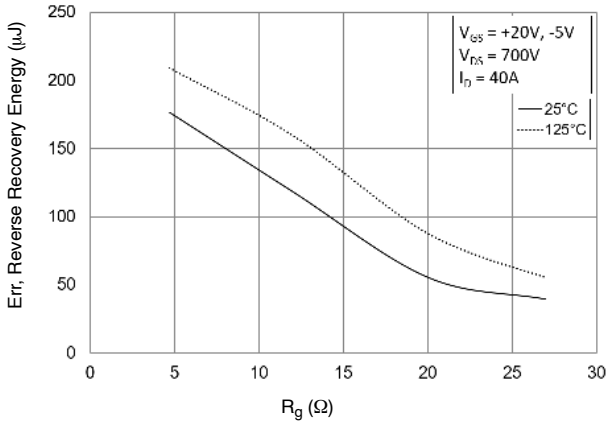
## TYPICAL CHARACTERISTICS – MOSFET, BOOST DIODE AND BYPASS DIODE (continued)



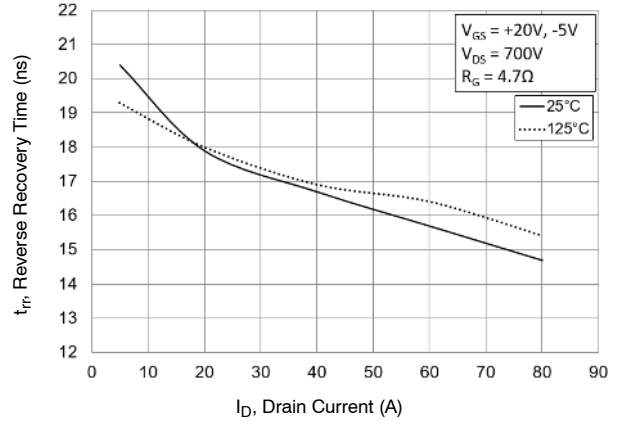
**Figure 14. Typical Turn-Off Switching Time vs.  $R_G$**



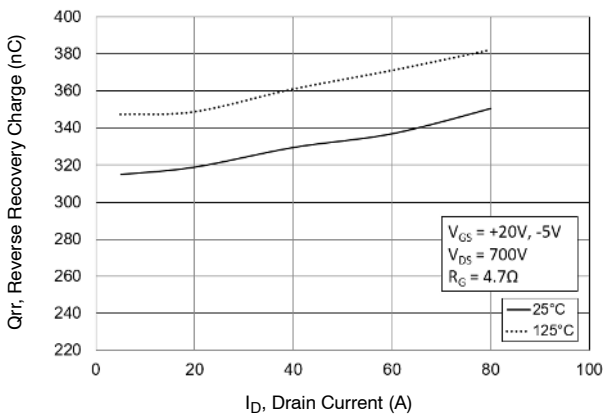
**Figure 15. Typical Reverse Recovery Energy Loss vs.  $I_D$**



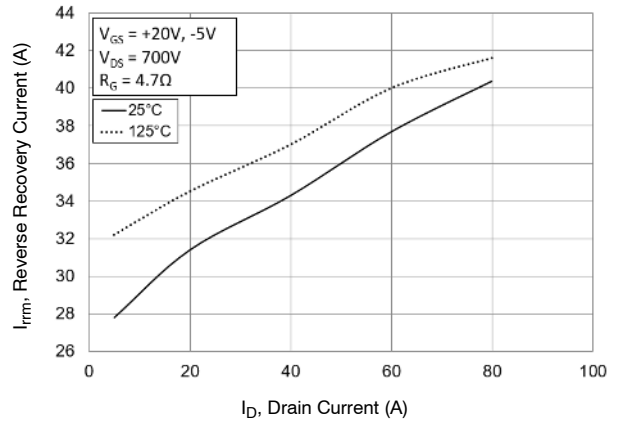
**Figure 16. Typical Reverse Recovery Energy Loss vs.  $R_G$**



**Figure 17. Typical Reverse Recovery Time vs.  $I_D$**



**Figure 18. Typical Reverse Recovery Charge vs.  $I_D$**



**Figure 19. Typical Reverse Recovery Peak Current vs.  $I_D$**

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## TYPICAL CHARACTERISTICS – MOSFET, BOOST DIODE AND BYPASS DIODE (continued)

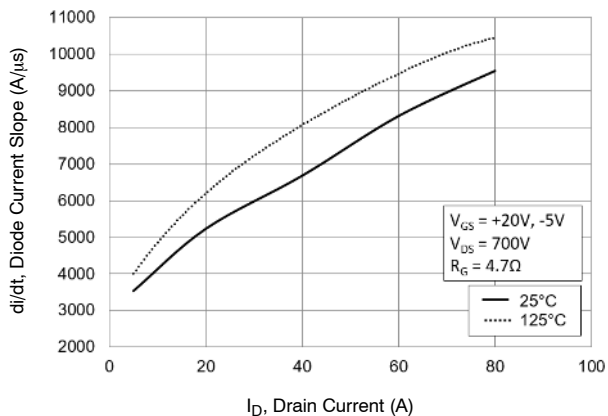


Figure 20. Typical di/dt Current Slope vs.  $I_D$

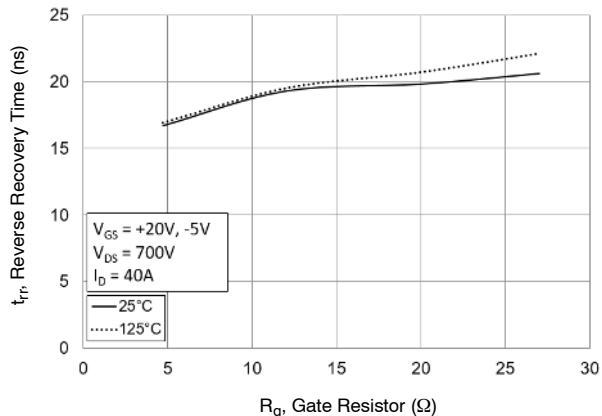


Figure 21. Typical Reverse Recovery Time vs.  $R_G$

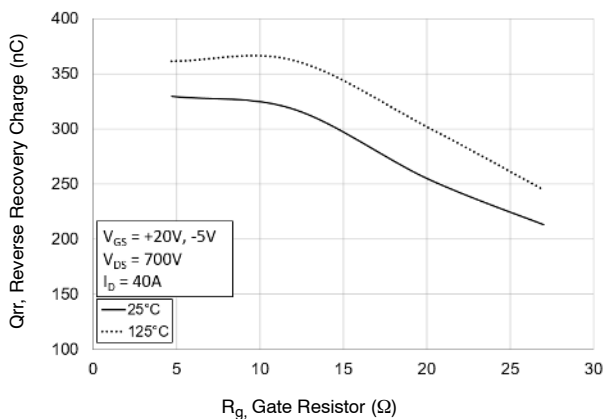


Figure 22. Typical Reverse Recovery Charge vs.  $R_G$

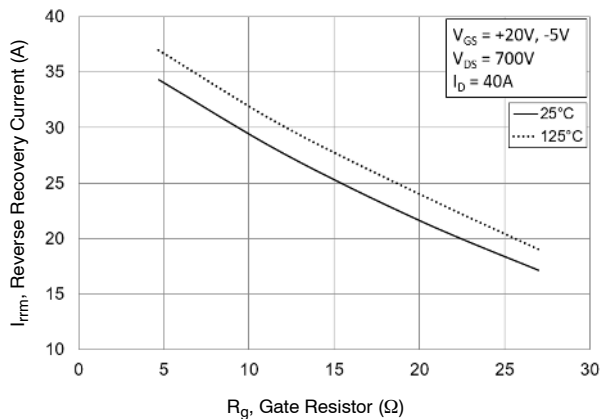


Figure 23. Typical Reverse Recovery Peak Current vs.  $R_G$

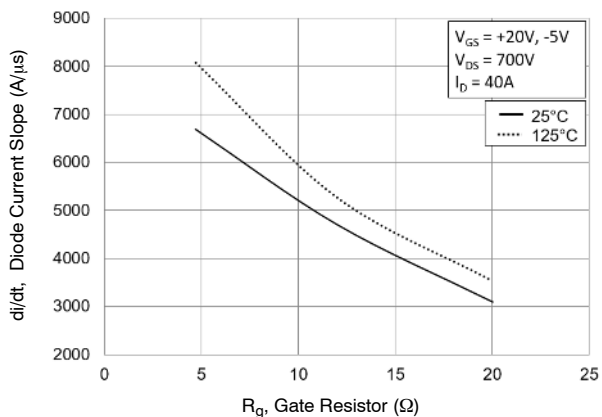


Figure 24. Typical di/dt vs.  $R_G$

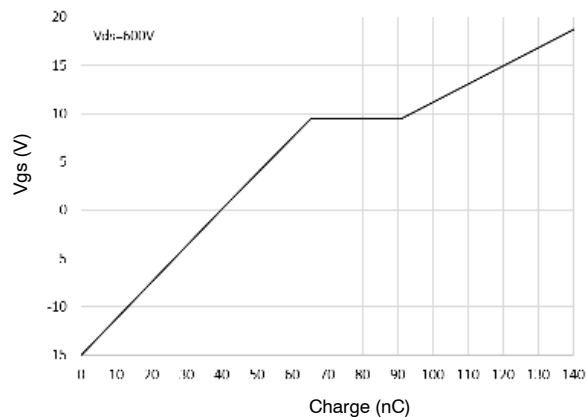


Figure 25. Gate Voltage vs. Gate Charge



# NXH40B120MNQ0SNG

## TYPICAL CHARACTERISTICS – MOSFET, BOOST DIODE AND BYPASS DIODE (continued)

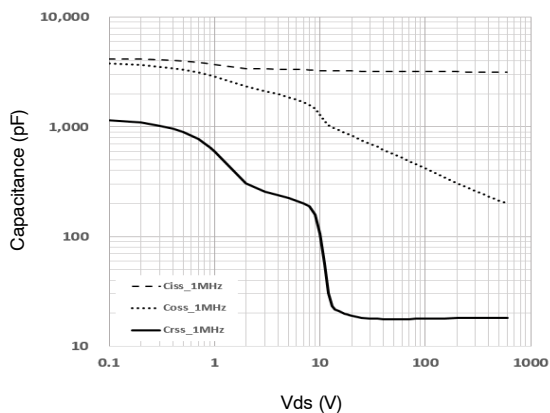


Figure 26. Capacitance Charge

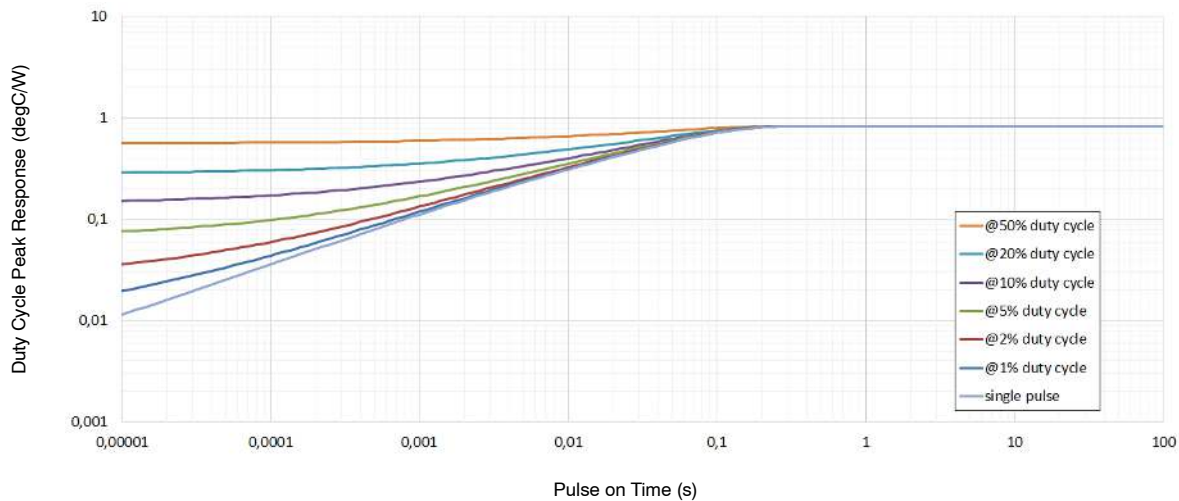


Figure 27. Mosfet Transient Thermal Impedance

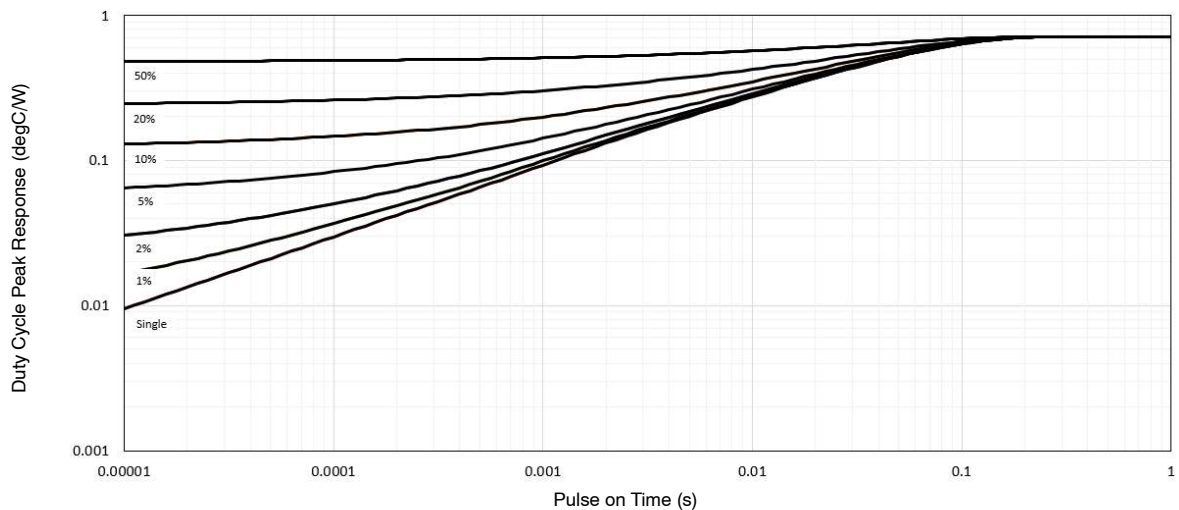
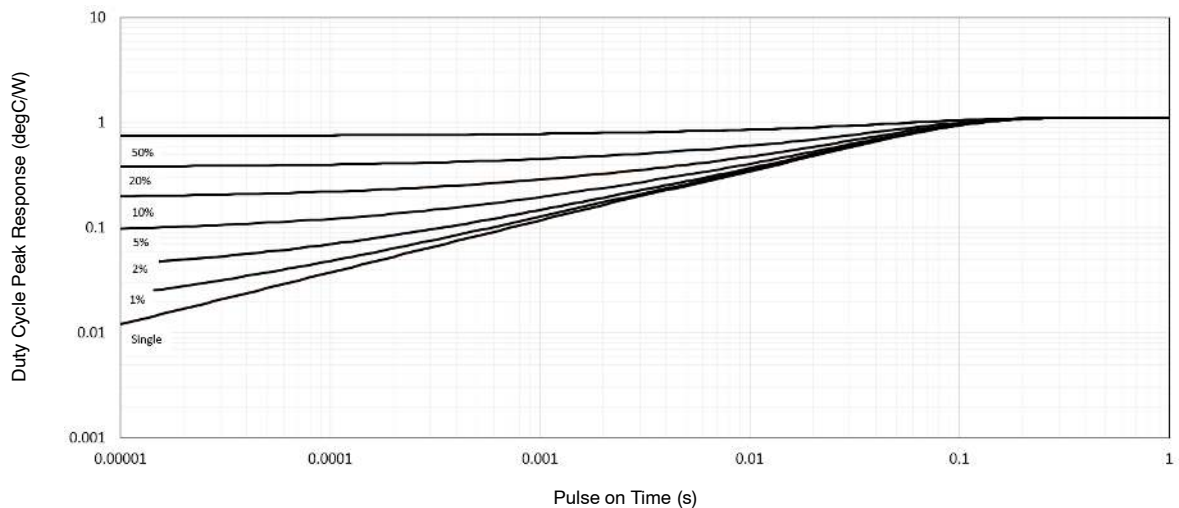


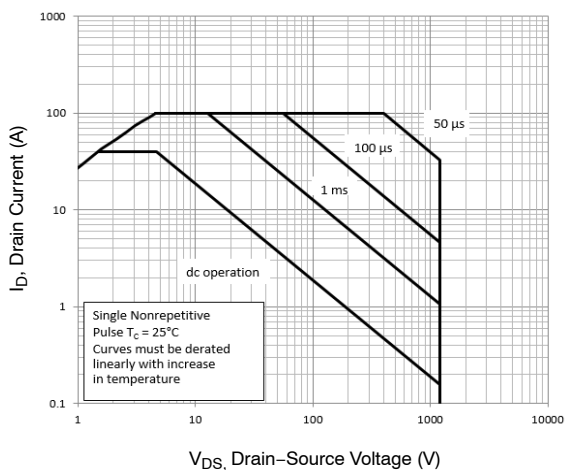
Figure 28. Boost Diode Transient Thermal Impedance

# NXH40B120MNQ0SNG

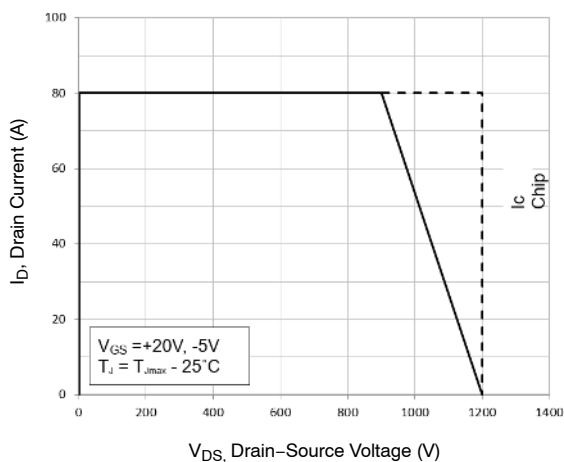
## TYPICAL CHARACTERISTICS – MOSFET, BOOST DIODE AND BYPASS DIODE (continued)



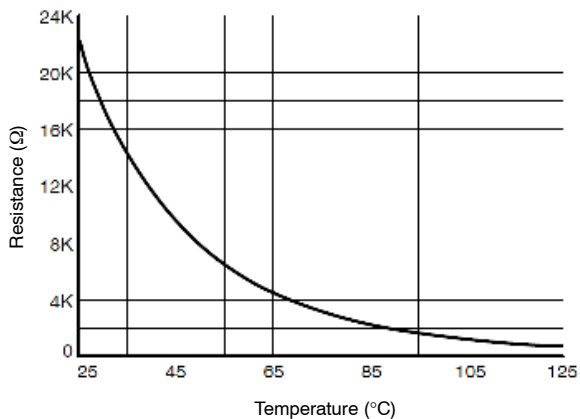
**Figure 29. Bypass Diode Transient Thermal Impedance**



**Figure 30. FBSOA for MOSFET**



**Figure 31. RBSOA for MOSFET**



**Figure 32. Thermistor Characteristics**

# MECHANICAL CASE OUTLINE

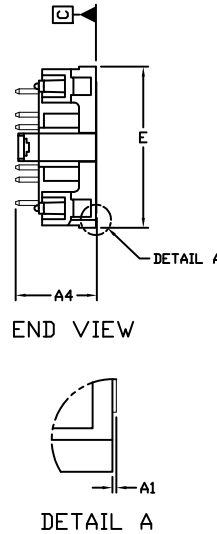
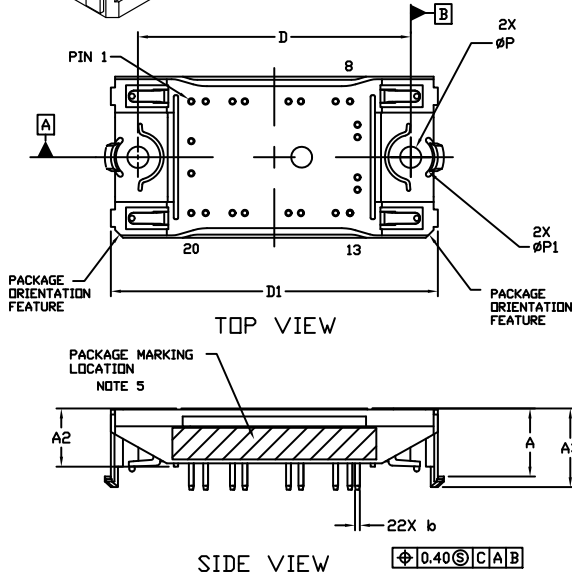
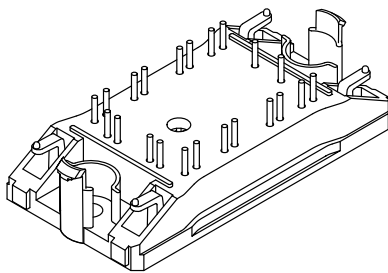
## PACKAGE DIMENSIONS

ON Semiconductor®



### PIM22, 55x32.5 / Q0BOOST CASE 180AJ ISSUE B

DATE 08 NOV 2017



**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSION **b** APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

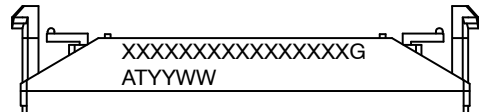
DIM	MILLIMETERS	
	MIN.	NDM.
A	13.50	13.90
A1	0.10	0.30
A2	11.50	11.90
A3	15.65	16.05
A4	16.35	REF
b	0.95	1.05
D	54.80	55.20
D1	65.60	66.20
E	32.20	32.80
P	4.20	4.40
P1	8.90	9.10

**MOUNTING HOLE POSITION**

NOTE 4

PIN	HOLE POSITION		PIN	PIN POSITION		PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y		X	Y		X	Y
1	-16.75	-11.25	12	16.75	6.55	1	-16.75	11.25	12	16.75	-6.55
2	-13.85	-11.25	13	15.25	11.25	2	-13.85	11.25	13	15.25	-11.25
3	-8.45	-11.25	14	12.35	11.25	3	-8.45	11.25	14	12.35	-11.25
4	-5.95	-11.25	15	5.35	11.25	4	-5.95	11.25	15	5.35	-11.25
5	2.85	-11.25	16	2.85	11.25	5	2.85	11.25	16	2.85	-11.25
6	5.35	-11.25	17	-5.95	11.25	6	5.35	11.25	17	-5.95	-11.25
7	12.35	-11.25	18	-8.45	11.25	7	12.35	11.25	18	-8.45	-11.25
8	15.25	-11.25	19	-13.85	11.25	8	15.25	11.25	19	-13.85	-11.25
9	16.75	-6.55	20	-16.75	11.25	9	16.75	6.55	20	-16.75	-11.25
10	16.75	-4.05	21	-16.75	3.25	10	16.75	4.05	21	-16.75	-3.25
11	16.75	4.05	22	-16.75	-3.25	11	16.75	-4.05	22	-16.75	3.25

**GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code  
 G = Pb-Free Package  
 AT = Assembly & Test Site Code  
 YYWW = Year and Work Week Code

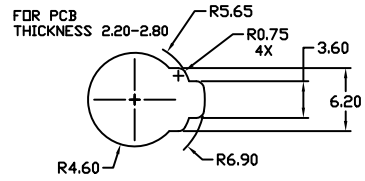
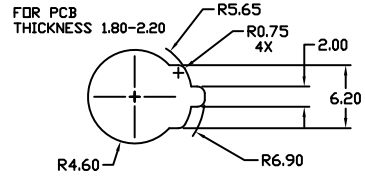
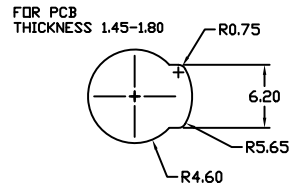
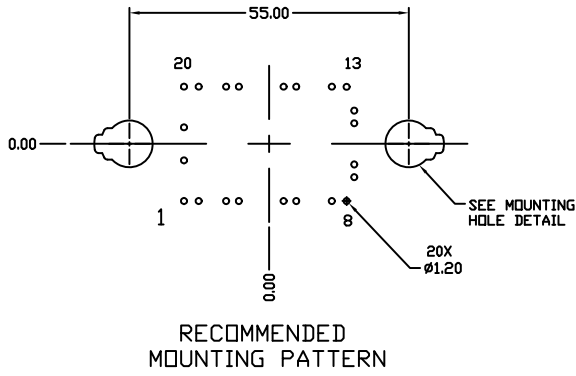
\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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PIM22, 55x32.5 / Q0BOOST  
CASE 180AJ  
ISSUE B

DATE 08 NOV 2017



MOUNTING HOLE DETAIL

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